ARMI MBH

Certified Reference Material

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Certificate of Analysis



Revision No.: 000

Revision Date: 01/18/2024

Product ID: MBH-31X BIB2-21

Product Description: BISMUTH-BRASS (CHILL CAST)

Description and Intended Use: This Certified Reference Material is covered under the scope of accreditation to ISO 17034 by LGC Standards - Manchester, NH. As an ISO 17034 certified reference material, appropriate use of this material will fulfill the certified reference material and traceability requirements for use in ISO 17025 accredited laboratories. This CRM may come in the form of a solid disk, or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods. Cartified Values listed in ut 9/ with appaalated uppartaintia

		Certil	ied values listed in wt.	% with a	ssociated uncertainties			
Al	0.81 ± 0.02	As	0.025 ± 0.002	Bi	1.11 ± 0.02	Cd	0.0062	± 0.0004
Co	0.026 ± 0.002	Cu	58.7 ± 0.2	Fe	0.122 ± 0.005	Mn	0.0258	± 0.0009
Ni	0.58 ± 0.01	Р	0.035 ± 0.003	Pb	0.131 ± 0.004	Sb	0.083	± 0.004
Si	0.18 ± 0.01	Sn	1.31 ± 0.03	Zn	37.1 ± 0.2			

Indicative Values listed in ppm

40 B 2 S 8 Se 19 Ag

Homogeneity and Uncertainty: "Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where Nprod is the number of units produced and Nmin is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculated uncertainty due to inhomogeneity (Uhom). Uncertainty of the material is calculated by equation 2, where H=U_{hom}, S= Standard deviation, t= t-value at 95% CI, and n= number of observations.

$$1.N_{MIN} = \max(10, \sqrt[3]{N_{PROD}})$$

$$2.U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} *$$

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Certification Laboratories: Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials. Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

- AnchorCert Birmingham, England
 - Dirats Laboratories Westfield MA
- Genitest Inc Montreal, Canada Instytut Metalurgii Zelaza - Gliwice, Poland •
- Lithea S.R.O. Brno, Czech Republic NSL Analytical Services - Cleveland, OH •

- Elemental Analysis Inc. Lexington, KY
- . EAG Laboratories - Liverpool, NY •
- Sheffield Assay Office Sheffield, England Universal Scientific Laboratory Pty Ltd - New South Wales, Australia

Instructions for Use: The test surface is on the opposite side of the labeled surface, which includes the material identification. This material is individually chill cast per piece. This manner of casting can cause the formation of inhomogeneous segregates in the upper, engraved portion of the disk. Therefore, the certification information above is not applicable to within 3mm of the engraved surface. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use. Chips are not recommended for gas analysis.

Period of Validity: The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

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Chuck Goudreau, Certifying Officer

Conditions of Sale and Supply: All CRMs & RMs sold are subject to applicable LGC Standard Terms and Conditions of Sale.

18 January 2024

Certification Date



ISO 17034 Accredited: Reference Materials Producer, Certificate # 2848.02 ISO/IEC 17025 Accredited: Chemical Testing, Certificate # 2848.01



Laboratory Testing, Inc. - Hatfield, PA LGC Standards - Manchester, NH

The following data represents all pertinent information reported as it applies to the chemical characterization of this material.

	Ag	AI	As	В	Bi	Cd	Co	Cu	Fe	Mn	Ni	Р	Pb
1	0.0040	0.7610	0.0190	0.0001	1.065	0.0051	0.0200	58.45	0.1018	0.0240	0.5310	0.0292	0.1200
2		0.7710	0.0200	0.0002	1.080	0.0059	0.0229	58.51	0.1200	0.0246	0.5691	0.0304	0.1240
3		0.7960	0.0219	0.0003	1.081	0.0060	0.0230	58.53	0.1210	0.0250	0.5800	0.0310	0.1299
4		0.8010	0.0240	<0.0001	1.085	0.0060	0.0250	58.58	0.1227	0.0253	0.5811	0.0323	0.1300
5		0.8040	0.0242	<0.001	1.105	0.0061	0.0254	58.67	0.1240	0.0253	0.5840	0.0330	0.1302
6		0.8053	0.0252	<0.0010	1.123	0.0061	0.0255	58.68	0.1241	0.0259	0.5899	0.0336	0.1320
7		0.8223	0.0262	<0.005	1.127	0.0062	0.0257	58.82	0.1243	0.0262	0.5900	0.0339	0.1320
8		0.8240	0.0271		1.134	0.0062	0.0268	59.04	0.1251	0.0271	0.5910	0.0340	0.1350
9		0.8302	0.0280		1.138	0.0065	0.0275		0.1260	0.0271	0.5930	0.0380	0.1363
10		0.8339	0.0281		1.146	0.0070	0.0277		0.1280	0.0280	0.5950	0.0380	0.1370
11		0.8470	0.0290			0.0071	0.0340		0.1300		0.5970	0.0413	0.1376
12		0.8540				<0.005						0.0450	
Mean	0.0040	0.8125	0.0248	0.0002	1.108	0.0062	0.0258	58.66	0.1225	0.0258	0.5819	0.0350	0.1313
STDV		0.0283	0.0034	0.0001	0.029	0.0005	0.0035	0.19	0.0074	0.0013	0.0187	0.0047	0.0055
Certified	(0.0040)	0.81	0.025	(0.0002)	1.11	0.0062	0.026	58.7	0.122	0.0258	0.58	0.035	0.131
U _{CRM}		0.02	0.002		0.02	0.0004	0.002	0.2	0.005	0.0009	0.01	0.003	0.004
Methods		1,0	I,IM,O	I,IM	I,O	I,IM,O	I,IM,O	I,W	I,IM,O	I,IM	I,O	I,IM,W,O	I,IM,O

	S	Sb	Se	Si	Sn	Zn
1	0.0002	0.0700	0.0010	0.1500	1.200	36.57
2	0.0007	0.0781	0.0014	0.1520	1.238	36.84
3	0.0009	0.0790	0.0015	0.1660	1.280	36.85
4	0.0010	0.0796	0.0015	0.1736	1.297	36.86
5	0.0012	0.0827	0.0015	0.1774	1.298	36.91
6	<0.0005	0.0835	0.0032	0.1820	1.303	36.95
7	<0.001	0.0840	0.0034	0.1900	1.310	37.02
8	<0.0050	0.0849	<0.005	0.1907	1.321	37.19
9		0.0886	<0.005	0.2020	1.336	37.25
10		0.0892			1.347	37.65
11		0.0915			1.359	37.73
12					1.379	
Mean	0.0008	0.0828	0.0019	0.1760	1.306	37.07
STDV	0.0004	0.0061	0.0009	0.0176	0.050	0.36
Certified	(0.0008)	0.083	(0.0019)	0.18	1.31	37.1
UCRM		0.004		0.01	0.03	0.2
Methods	C,I	I,IM,O	I,IM	I,IM,W,O	I,O	I,W,O

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES